

Why Teach TXRF: Trace Elemental Analysis in the University Laboratory



Bruker AXS Inc., Madison, WI, USA
March 7, 2013

A blue-themed graphic for TXRF. On the left, a portion of the periodic table is shown with elements like Ga, Sc, Ti, Sr, Y, Zr, Ba, La, Hf, Ra, and Ac. In the center, the text "XFlash® Technology" is positioned above a spectral plot showing peaks for various elements (V, Cr, Mn, Fe, Ni, Cu, Zn, Ga, Ge, As, Se, Br, Rb, Sr, Y, Zr, Nb, Mo, Tc, Ru, Rh, Pd, Ag, Cd, In, Sn, Sb, Te, I, Xe, Ta, W, Re, Os, Ir, Pt, Au, Hg, Tl, Pb, Bi, Po, At, Rn) against a keV scale. Below the plot, another portion of the periodic table shows elements from Ce to Lu and Th to U. On the right, the text "TXRF" is displayed in a large, white, serif font. At the bottom, a schematic of a TXRF instrument is shown, including a sample stage, a detector, and a monitor. The background features a faint atomic symbol and a glowing light effect.

Welcome



Today's Topics

- Introduction to TXRF, learn about X-ray fluorescence analysis
- Analysis of a rum sample
- Straightforward data evaluation
- Sample preparation
- Examples of research applications
- Comparison with atomic spectroscopy methods

Speakers



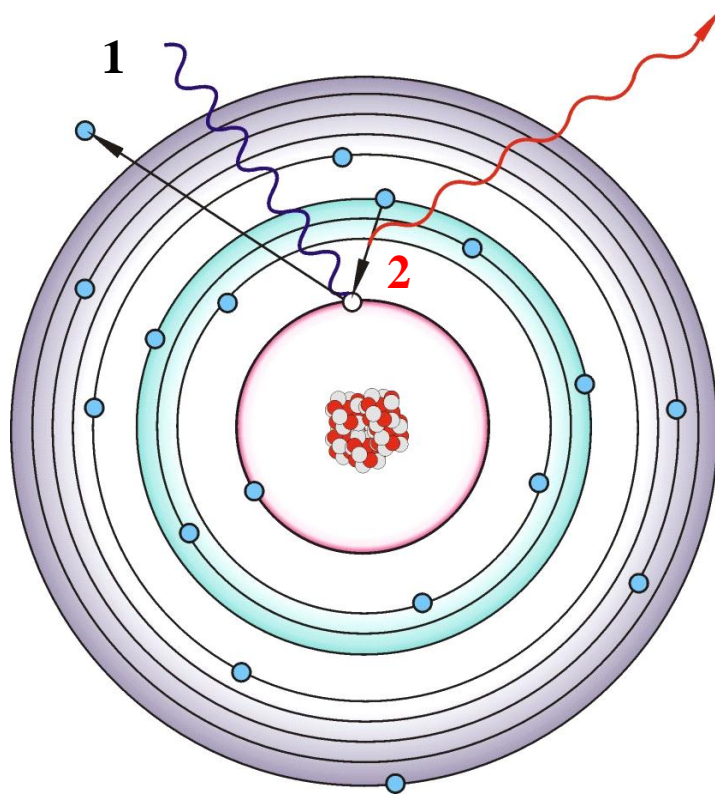
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Business Development Manager
Americas - XRFi
Madison, WI, USA

TXRF – How does it work?

Principles X-ray Fluorescence (XRF) Spectroscopy



3

1. An X-ray quantum hits an inner shell electron in a (sample) atom. The electron is removed leaving the atom in an excited state
2. The missing inner shell electron is replaced by an electron from an outer shell
3. The energy difference between the inner and outer shell is balanced by the emission of a photon (fluorescence radiation)

Principles X-ray Fluorescence (XRF) Spectroscopy

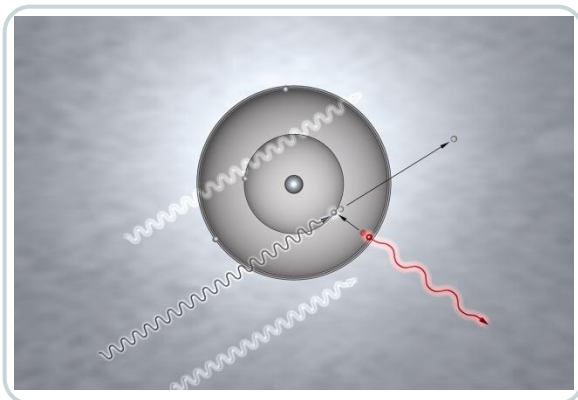


- The energy, and therefore the wavelength, of the X-ray fluorescence radiation is characteristic for the different chemical elements.

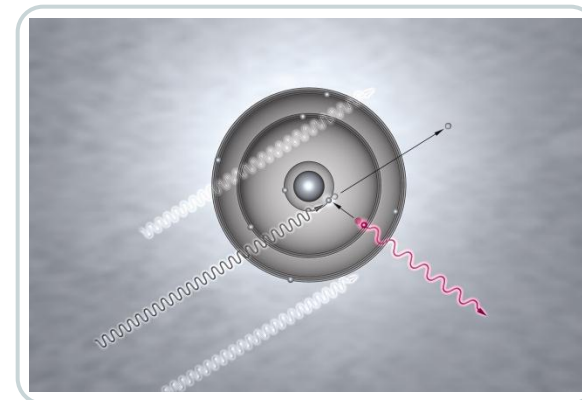
QUALITATIVE ANALYSIS

- The intensity of the X-ray fluorescence radiation is, in first approximation, proportional to the element concentration.

QUANTITATIVE ANALYSIS



Low Z



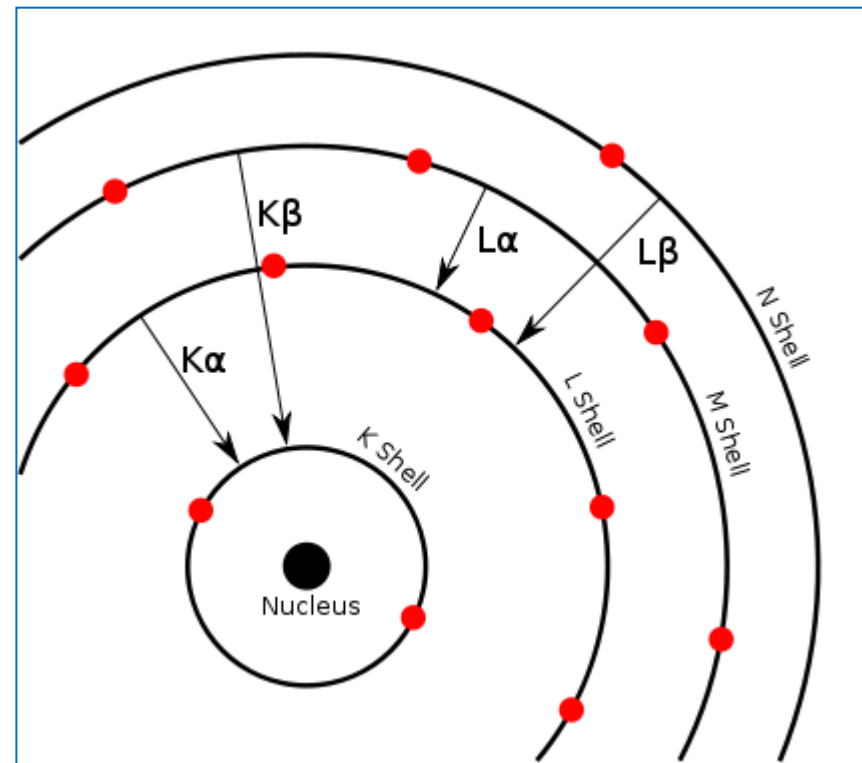
High Z

Principles of X-ray Fluorescence (XRF) Spectroscopy

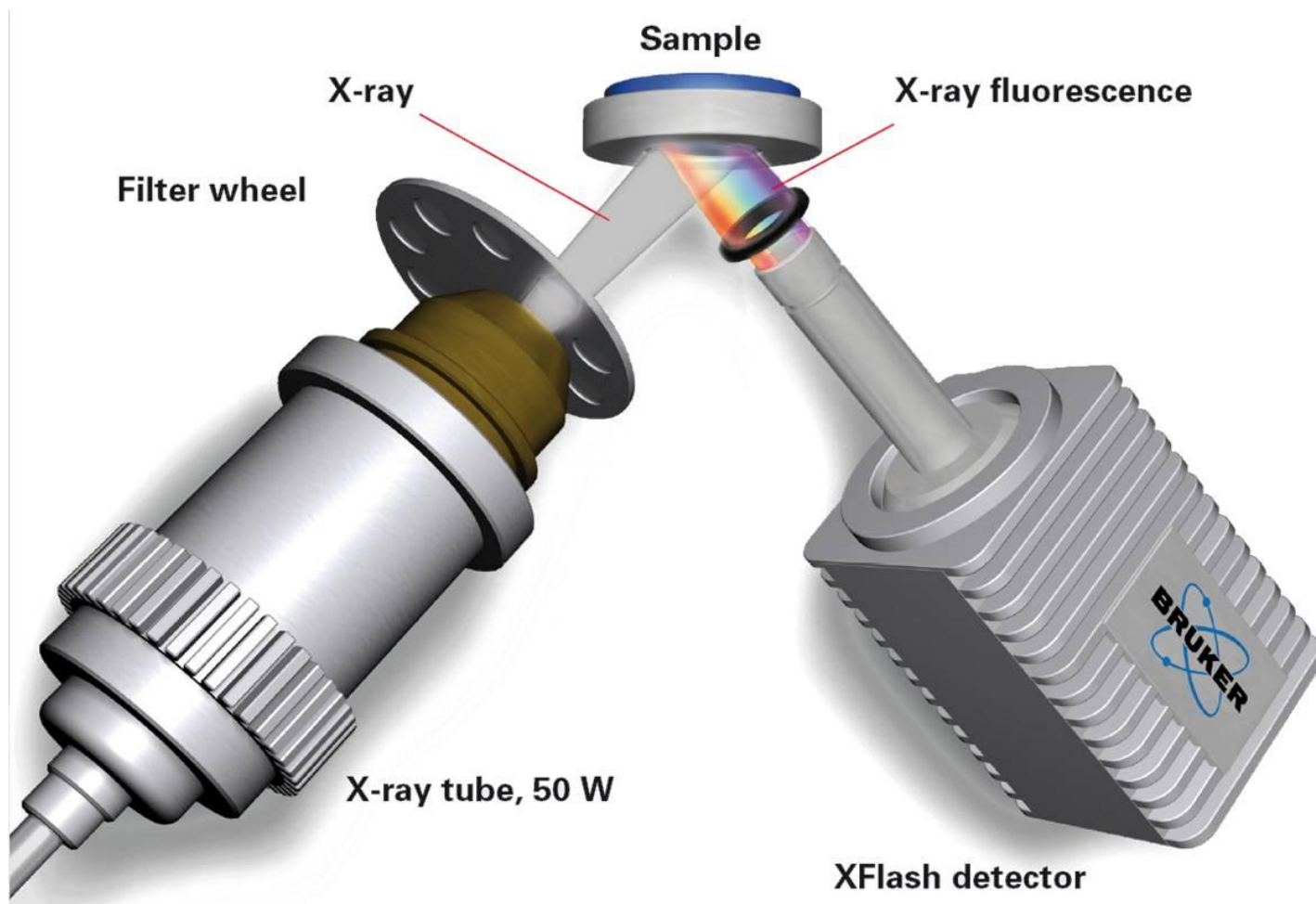


Each element shows a specific line pattern in a spectrum depending on the orbitals involved

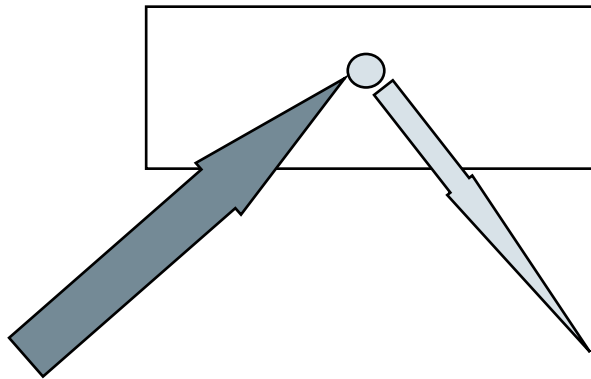
- L→K transition = $K\alpha$ line
- M→K transition = $K\beta$ line
- M→L transition = $L\alpha$ line
- N→L transition = $L\beta$ line



Traditional EDXRF



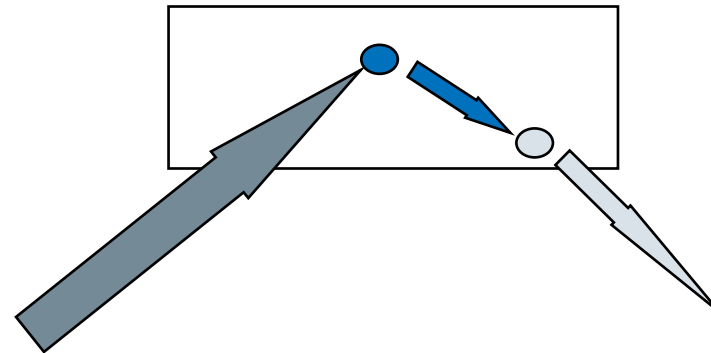
Traditional EDXRF Quantification



absorption of primary beam
and fluorescence radiation

$$I_i = f(c_i, c_j)$$

and



secondary fluorescence
enhancement

$$c_i = f(I_i, c_j)$$

Concentration needs to be determined
with matrix matched standards

DO YOU HAVE STANDARDS?

Traditional EDXRF

Samples for common XRF spectrometry (ED and WDXRF)

- Solids (cut, polished and put into suitable shape)
- Powders (as pressed pellets, fused beads or loose powders in liquid cups)
- Liquids (in liquid cups)

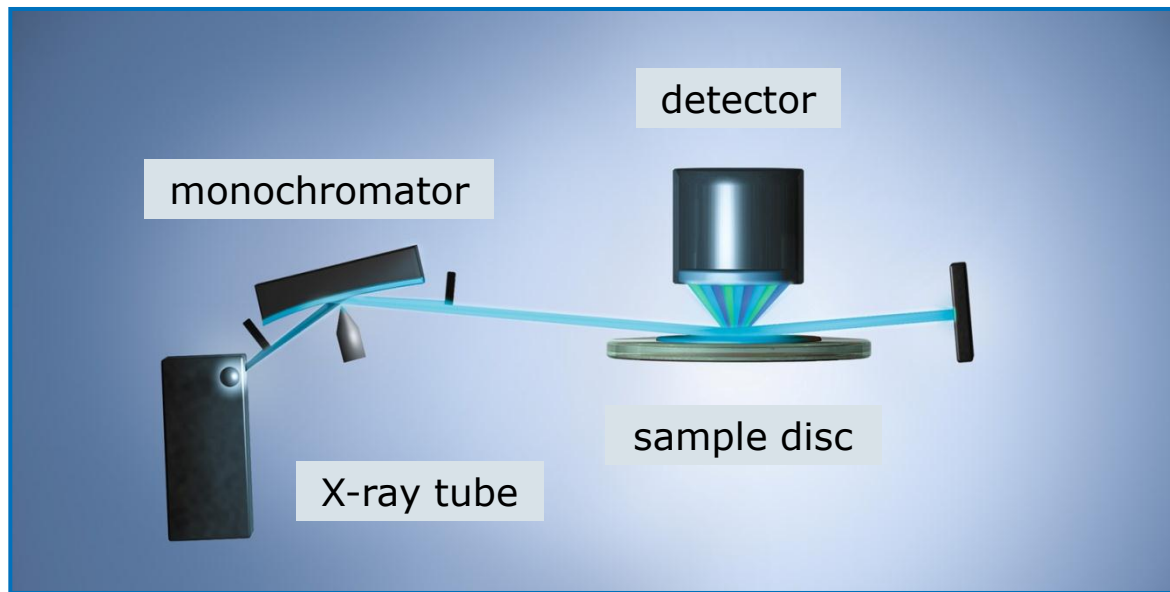
Necessary sample amount: from 1 g to 10 g!!



Principles of Total Reflection X-ray Fluorescence (TXRF) Spectroscopy



Total reflection X-ray fluorescence spectroscopy



Beam angle: $1^\circ / 90^\circ$

- Samples must be prepared on a reflective media
- Polished quartz glass or polyacrylic glass disc
- Dried to a thin layer, or as a thin film or microparticle

Principles of TXRF Quantification

$$C_i = \frac{C_{IS} \cdot N_i \cdot S_{IS}}{N_{IS} \cdot S_i}$$

C_i : Element concentration

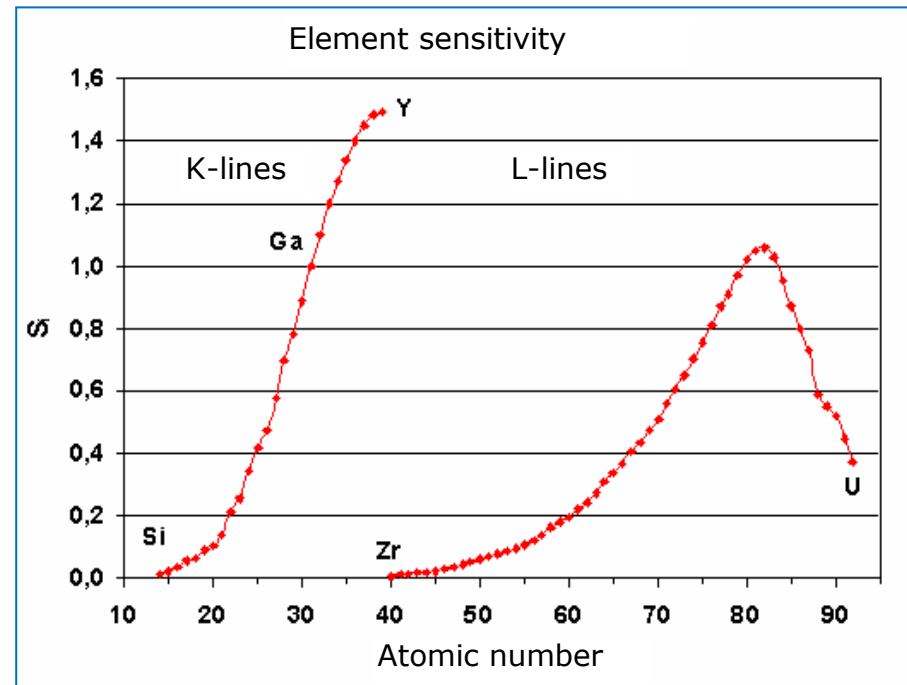
C_{IS} : Internal standard concentration

N_i : Element net count rate

N_{IS} : Internal standard net count rate

S_i : Element sensitivity factor

S_{IS} : Internal standard sensitivity factor



Principles of TXRF Quantification



Add internal standard to all blanks and samples

- Can compensate for (systematic and random) errors
- Standard should be similar to analyte in terms of instrumental response and concentration
- Standard should not be present in sample
- Good quantification and widely used



Principles of Total Reflection X-ray Fluorescence Spectroscopy

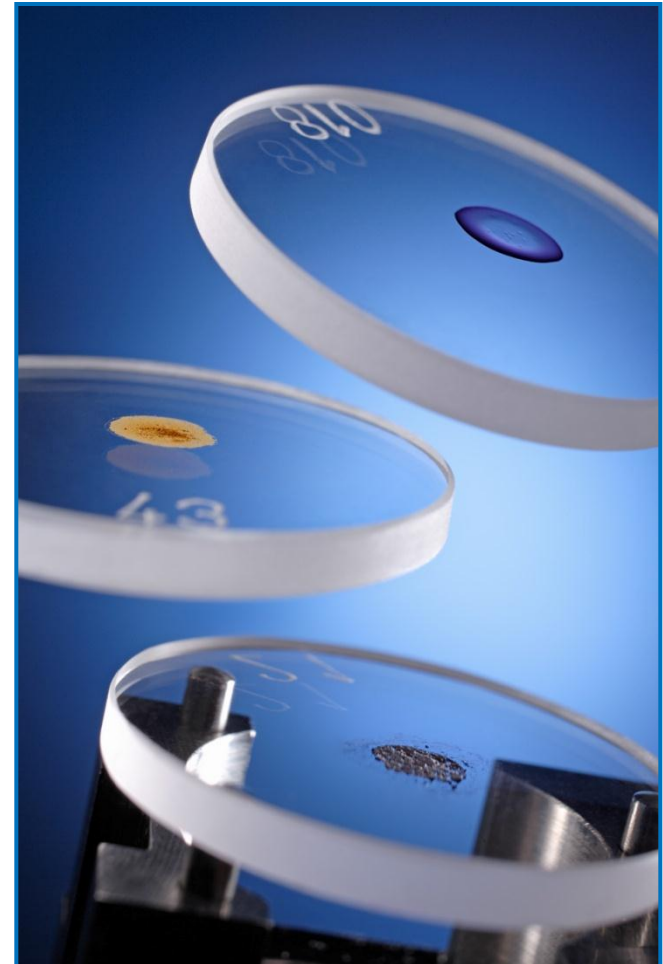


Samples for TXRF

- Powders: Direct preparation or as suspension
- Liquids: Direct preparation
- Always as a thin film, micro fragment or suspension of a powder
- Necessary sample amount: Low μg respectively μl range

Simple quantification

- Matrix effects are negligible due to thin layer
- Quantification is possible by internal standardization



Elements Measured by the Mo PICOFOX



H																	He
Li	Be											B	C	N	O	F	Ne
Na	Mg											Al	Si	P	S	Cl	Ar
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe
Cs	Ba	L	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn
Fr	Ra	A															
		L	La	Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
		A	Ac	Th	Pa	U	Np	Pu	Am	Cm	Ek	Cf	Es	Fm	Md	No	Lr

- Impossible to measure
- Difficult to measure
- Measured using K-lines
- Measured using L-lines

Elements Measured by the W PICOFOX



H																He	
Li	Be										B	C	N	O	F	Ne	
Na	Mg										Al	Si	P	S	Cl	Ar	
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe
Cs	Ba	L	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn
Fr	Ra	A															
		L	La	Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
		A	Ac	Th	Pa	U	Np	Pu	Am	Cm	Ek	Cf	Es	Fm	Md	No	Lr

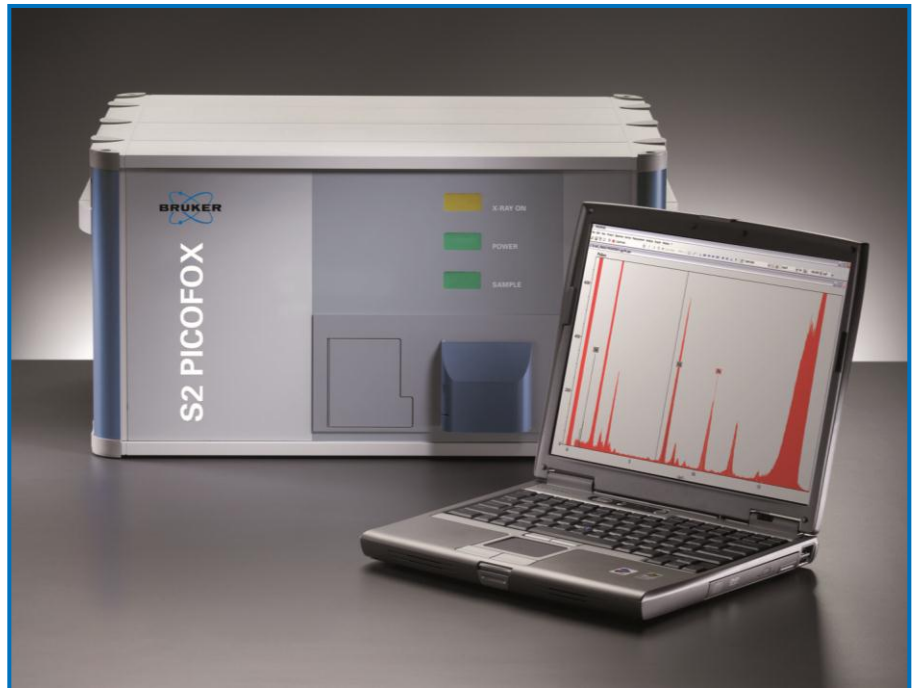
- Impossible to measure
- Difficult to measure
- Measured using K-lines
- Measured using L-lines

The Instrument S2 PICOFOX



Benchtop TXRF spectrometer S2 PICOFOX

- Metal-ceramic X-ray tube
 - Mo anode
 - Air-cooled
 - Other tubes available
- Multilayer monochromator
- XFlash[®] silicon drift detector
 - Electro-thermally cooled
 - ≤ 149 eV @ MnKa 100 kcps
- Automatic version
 - 25-sample cassette



Analysis of 18-Year-Old Rum

Analyzing Rum



Sample

- Rum, 18 years old
- Analyzing for Pb and other heavy metals

Current method of analysis

Flow-injection hydride-generation atomic absorption spectrometer with flame-quartz atomizer (FI-HG-AAS)

S2 PICOFOX TXRF spectrometer

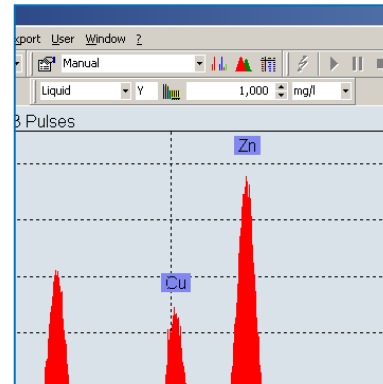


Sample Preparation of Our Rum Sample



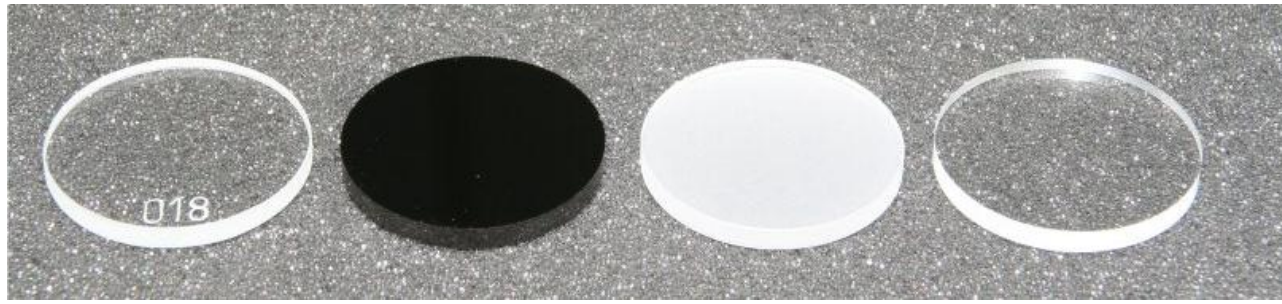
- fill sample in micro tube
 - add internal standard
 - homogenize
- pipette on carrier

Sample Preparation Final Steps



- dry by heat / vacuum
 - load the instrument
 - start data acquisition

Sample Carrier

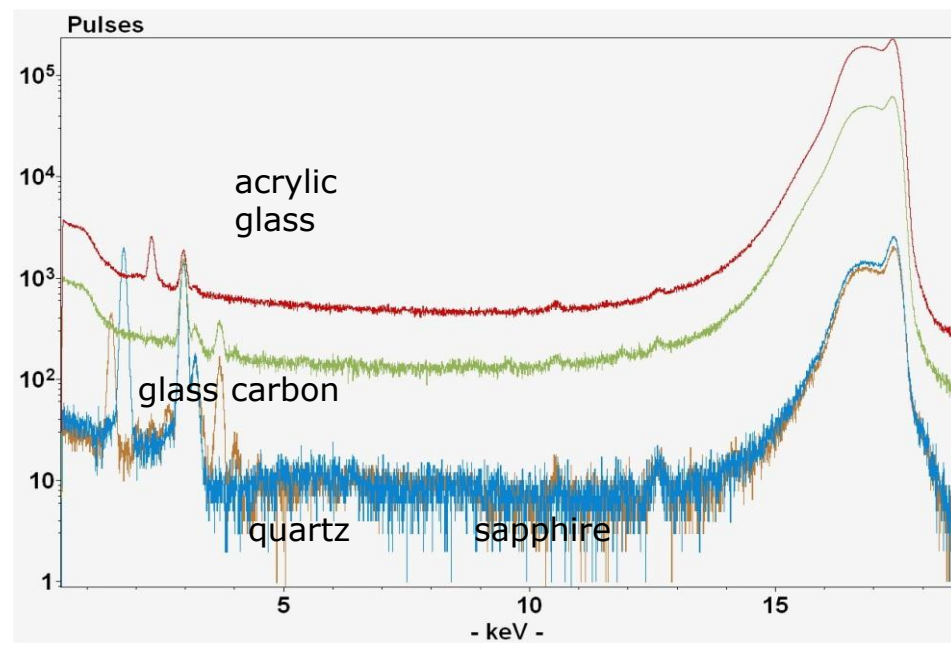


quartz glass

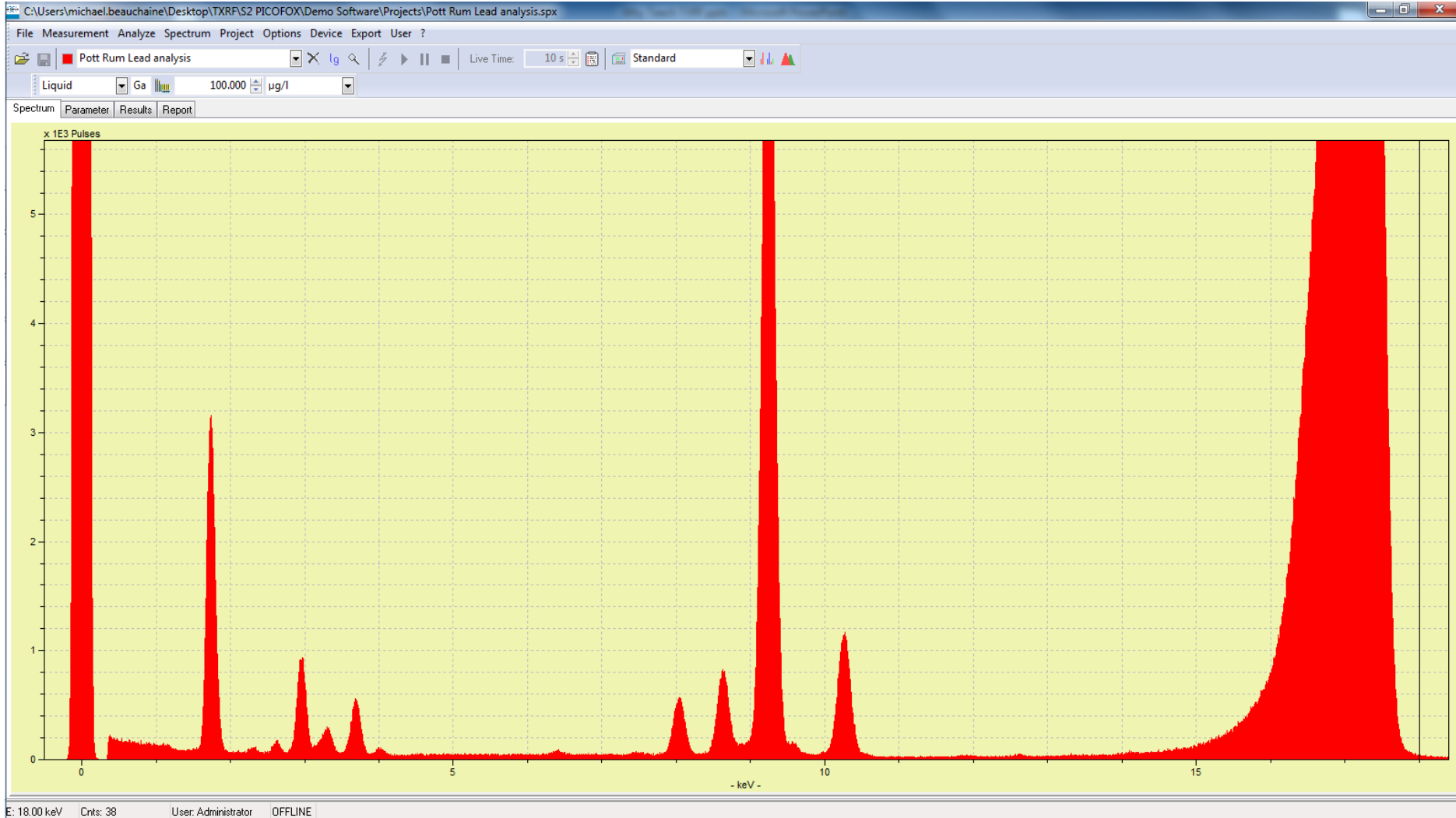
glass carbon

acrylic glass

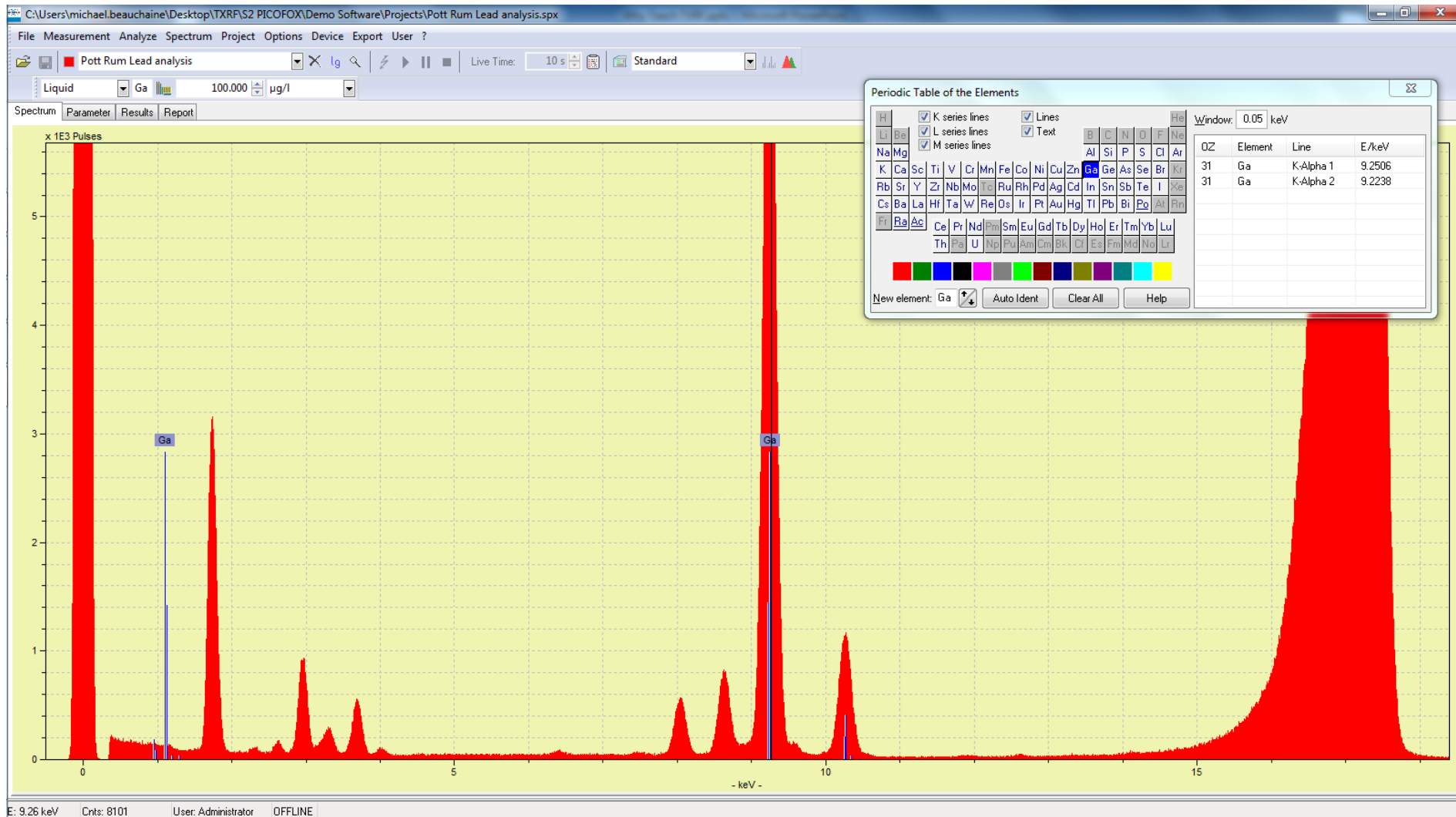
sapphire



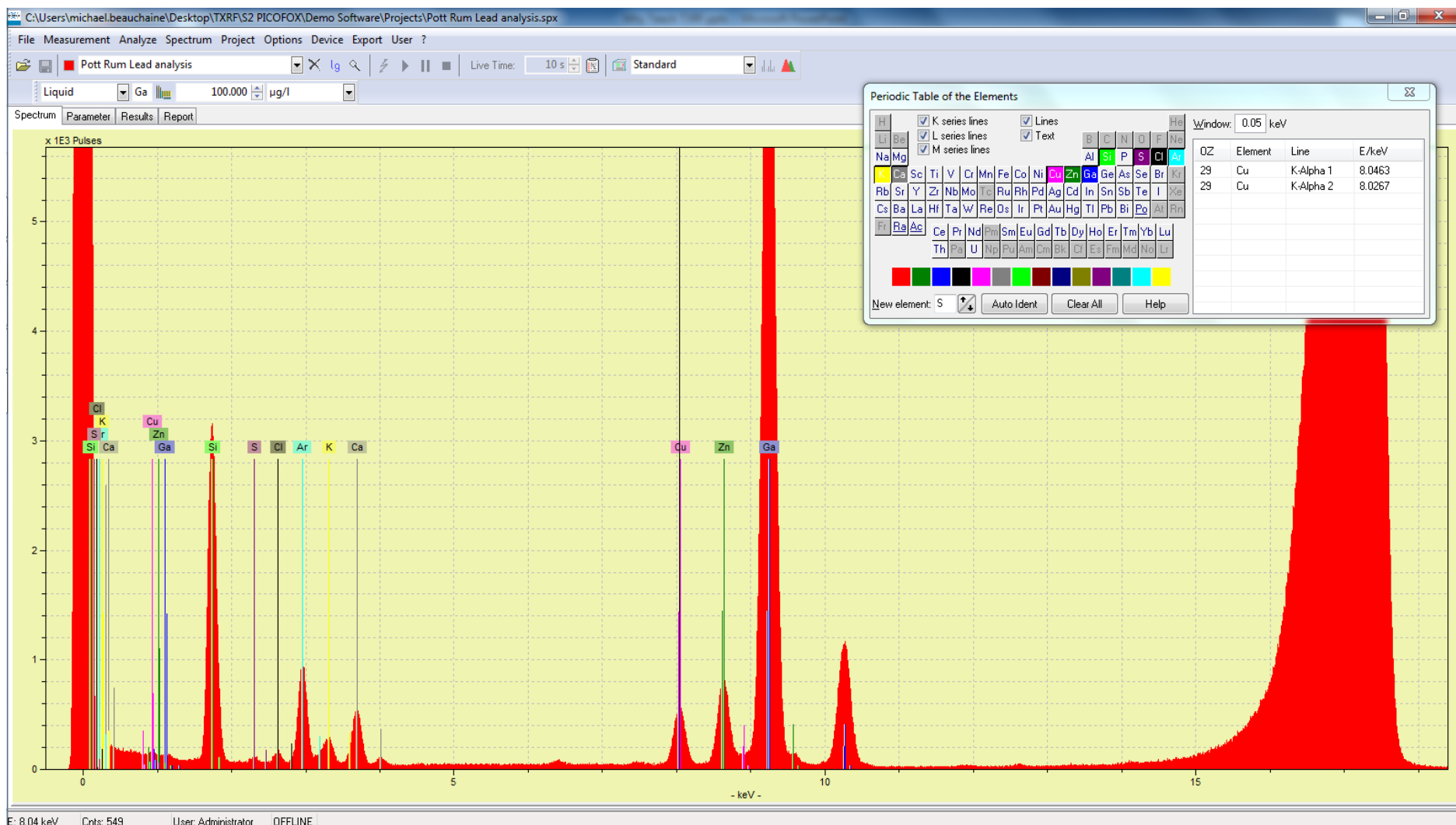
TXRF Rum Spectrum



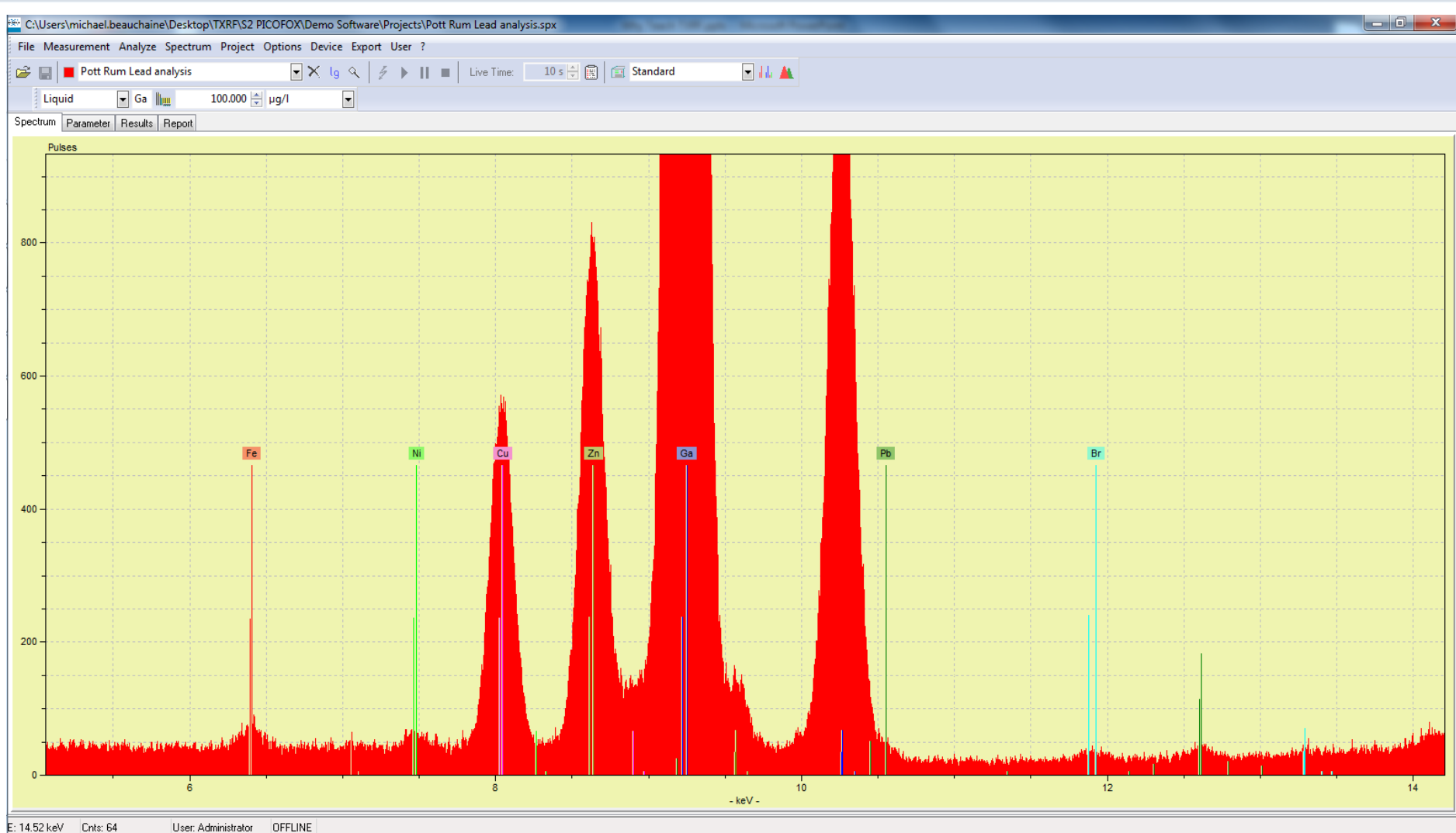
TXRF Rum Spectrum



TXRF Rum Spectrum



TXRF Rum Spectrum



TXRF Rum Results



C:\Users\michael.beauchaine\Desktop\TXRF\S2 PICOFOX\Demo Software\Projects\Pott Rum Lead analysis.spx

File Measurement Analyze Spectrum Project Options Device Export User ?

Pott Rum Lead analysis Live Time: 10 s Standard

Liquid Ga 100.000 µg/l

No.	Element	Line	Energy/keV	Cycl.	Net	Backgr.	Sigma	Chi	Conc./(µg/l)	SigmaC/(µg/l)	LLD/(µg/l)
1	Si	K12	1.740	51	78445	3439	292	0.90			
2	Cl	K12	2.622	251	3051	2323	88	0.95	30.774	0.889	1.459
3	Ar	K12	2.958	251	24841	2388	172	0.86			
4	K	K12	3.314	201	6393	2607	108	0.76	29.518	0.501	0.707
5	Ca	K12	3.692	301	14380	2268	138	1.22	33.620	0.326	0.334
6	Fe	K12	6.405	151	977	2902	82	1.45	0.654	0.055	0.108
7	Ni	K12	7.480	201	710	2988	82	1.20	0.327	0.038	0.076
8	Cu	K12	8.046	151	18976	3175	159	0.70	7.782	0.066	0.069
9	Zn	K12	8.637	251	28415	2804	184	0.95	10.026	0.066	0.056
10	Ga	K12	9.251	801	325234	2231	574	1.62	100.000	0.190	0.044
11	Ga	L1	1.098	1	1207	4797	104	5.63			
12	Br	K12	11.924	401	380	2247	70	0.76	0.084	0.015	0.031
13	Br	L1	1.481	51	464	3339	85	1.81			
14	Sr	K12	14.165	101	165	5479	105	1.08			0.045
15	Sr	L1	1.806	101	505	2868	79	1.07			
16	Mo	K12	17.480	1	985521	178077	1158	69.01			
17	Mo	L1	2.292	151	1688	2785	85	1.22			
18	Pb	L1	10.551	101	706	2089	70	1.37	0.249	0.025	0.048
19	Pb	M1	2.342	951	1	919	43	13.99			

TXRF Rum Results



Element	Energy/keV	Net	Backgr.	Sigma	Chi	Conc./($\mu\text{g/l}$)	SigmaC/($\mu\text{g/l}$)	LLD/($\mu\text{g/l}$)
Si	1.74	78445	3439	292	0.9			
Cl	2.622	3051	2323	88	0.95	30.774	0.889	1.459
Ar	2.958	24841	2388	172	0.86			
K	3.314	6393	2607	108	0.76	29.518	0.501	0.707
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Cu	8.046	18976	3175	159	0.7	7.782	0.066	0.069
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Ga	9.251	325234	2231	574	1.62	100	0.19	0.044
Br	11.924	380	2247	70	0.76	0.084	0.015	0.031
Pb	10.551	706	2089	70	1.37	0.249	0.025	0.048

Principles of TXRF Quantification

$$C_i = \frac{C_{IS} \cdot N_i \cdot S_{IS}}{N_{IS} \cdot S_i}$$

C_i : Element concentration

C_{IS} : Internal standard concentration

N_i : Element net count rate

N_{IS} : Internal standard net count rate

S_i : Element sensitivity factor

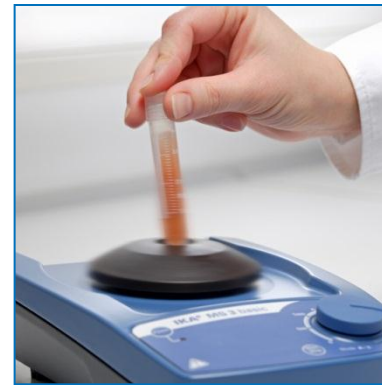
S_{IS} : Internal standard sensitivity factor

Other Sample Preparation Techniques

Sample Preparation Suspensions



Suspensions can be analyzed just after dilution



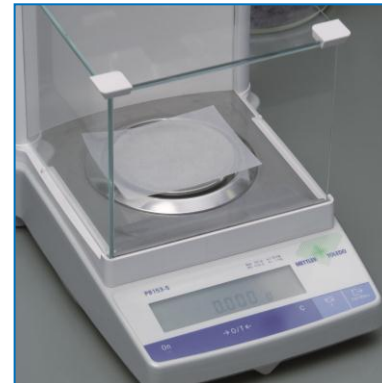
- dilute sample with distilled water
 - add internal standard
 - homogenize
- pipette on carrier

Sample Preparation

Solid and Powder Samples I



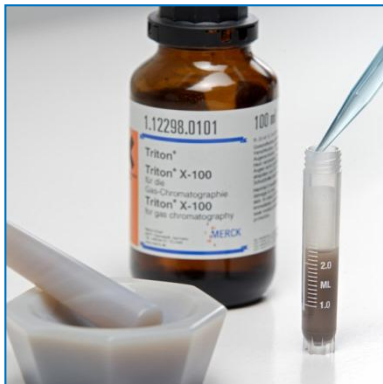
Solids are ground to fine particle size and resuspended for direct analysis without digestion



- fill powder in mortar
 - grind carefully ($<50 \mu\text{m}$)
 - weigh about 20-50 mg
 - transfer to tube

Sample Preparation

Solid and Powder Samples II

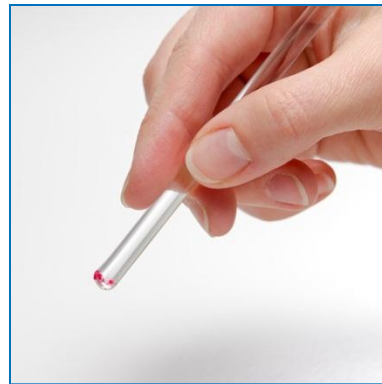


- suspend in detergent solution
 - add standard
- homogenize
- pipette on carrier

Sample Preparation Microparticles



Microparticles are measured semi-quantitatively and non-destructively



- dab vacuum grease on carrier
 - pick-up some particles with a (glass) rod
 - drop particles on grease

Application Examples

TXRF Applications

Blood, Serum and Urine Analysis



Introduction

- Analysis of nutrition-relevant elements (Cu, Fe, Zn, Se)
- Analysis of other toxic elements and Pt & Au (chemotherapy)

Task

- Analysis of whole blood and blood serum standards

Sample preparation

- Serum
 - 1:10 dilution with water (p.a. grade)
 - Addition of Ga for internal standardization
- Whole blood
 - 1:1 dilution with water (p.a. grade)
 - Addition of Ga for internal standardization



TXRF Applications

Blood, Serum and Urine Analysis

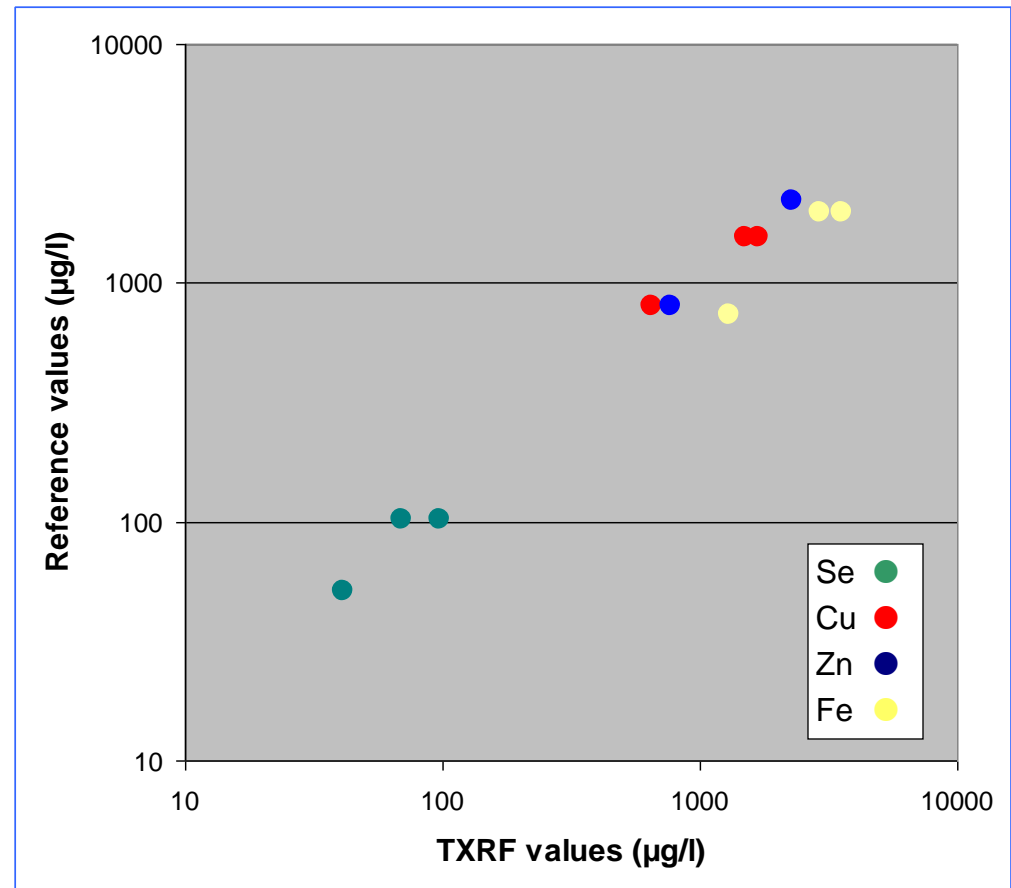


Results I

- Serum reference standard (t = 600 s)
- good correlation for Cu, Zn & Se
- overestimation of Fe improved calibration curve required

Note

Confidence level of reference values is up to 35 % (!)



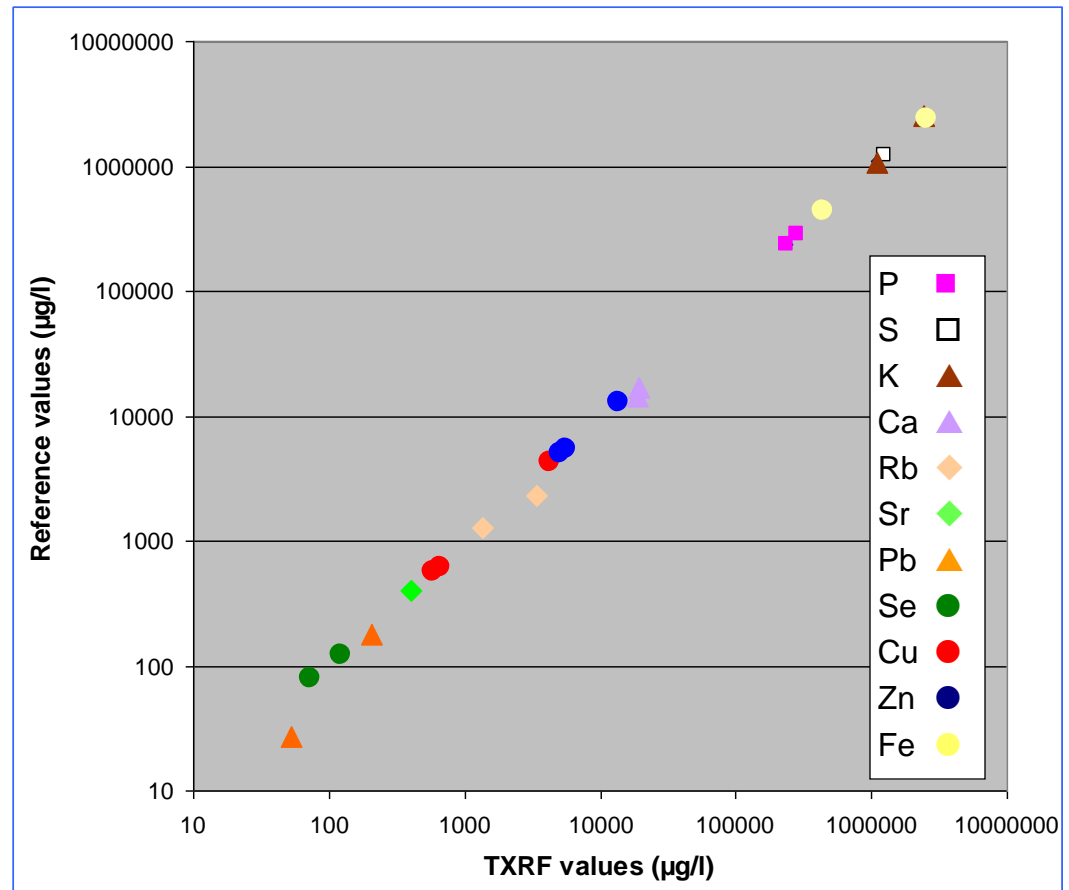
TXRF Applications

Blood, Serum and Urine Analysis



Results II

- Whole blood reference standard (t = 600 s)
- application of optimized "blood calibration"
- excellent correlation for Fe, Cu, Zn, Se and others



TXRF Applications

Blood, Serum and Urine Analysis



Reproducibility

Precise TXRF results even without sample digestion

Element	Unit	Serum (ClinCheck L2)				Whole blood (Seronorm L2)			
		TXRF	Std. dev.	Reference ¹⁾	Std. dev.	TXRF	Std. dev.	Reference ²⁾	Std. dev.
Fe	mg/l	440	7.4	435	12	2.9	0.09	1.964	0.20
Cu	µg/l	66	2.2	62	2.1	1685	43	1562	312
Zn	µg/l	501	4.9	504	6.9	2194	118	2225	334
Se	µg/l	12	0.29	12	1.0	97	18	102	26

1): Atomic Absorption Spectroscopy

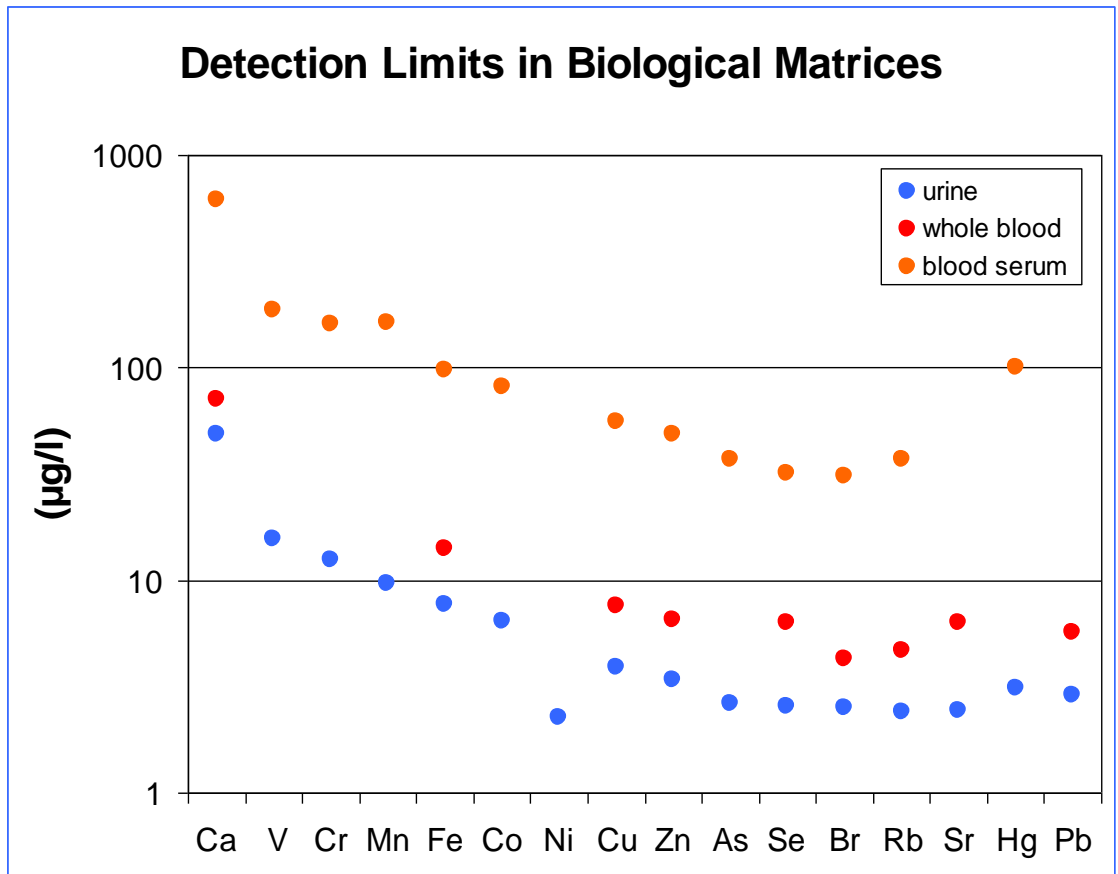
2): Sector-Field Inductively-Coupled Plasma Mass Spectroscopy

TXRF Applications

Blood, Serum and Urine Analysis



Detection limits are in the low to middle ppb range



Water Monitoring with Bioindicators

Introduction



Bioindicators are biological species used to:

- Monitor the health and integrity of an environment or ecosystem
- Monitor for changes of metal pollutions in surface waters and sediments

General questions

- Accumulation through the nutrition chain?
- Impact of sub-lethal metal concentrations?
- Methods for fast screening?

Water Monitoring with Bioindicators

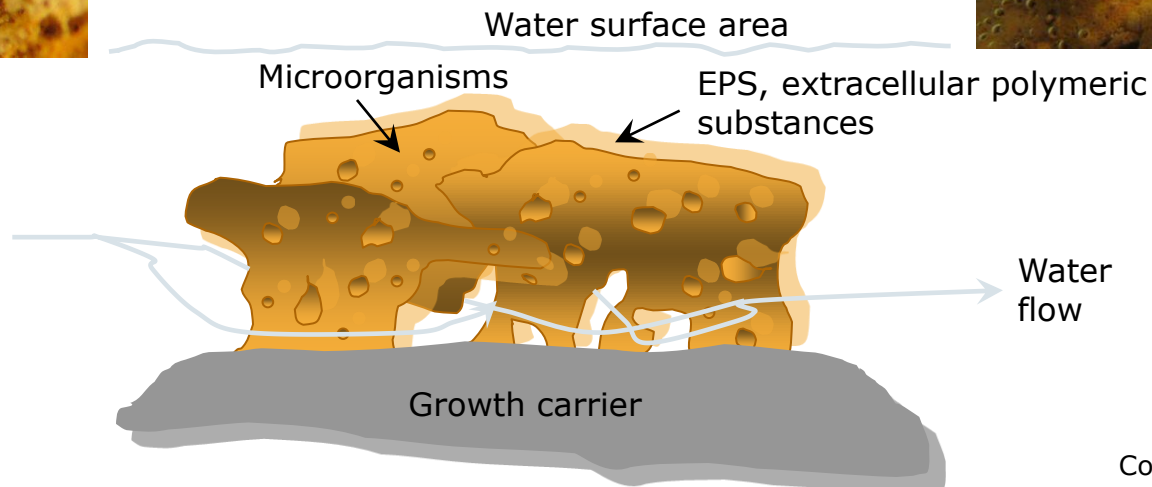
What are Biofilms?



Dry sample
microscopy photo



Wet sample
underwater photo



Courtesy of UFZ Magdeburg

Significance of Biofilms



Negative impact of biofilms

- Bioaccumulation of harmful chemicals in aquatic systems
- Biogenic corrosion of metals, concrete etc.
- Biofouling in pipeline systems
- Germination of water pipelines
- Contamination with pathogens in hospitals

Application of biofilms

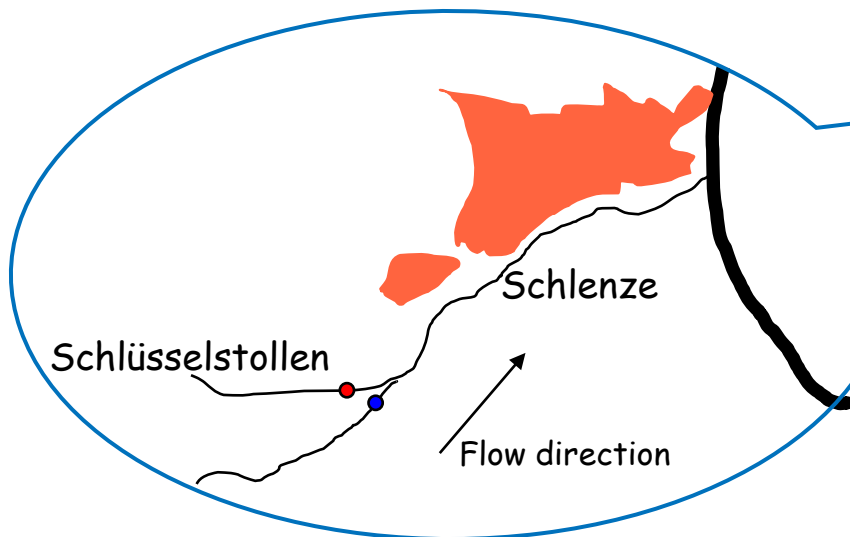
- Self-purification of waters
- Binding and removal of toxic materials
- Biotechnological use
- Removal of organics and N-compounds in wastewater treatment plants

Biofilms Sampling Location



Elbe watershed

Harz mountain range
mining area since bronze
age



Courtesy of UFZ Magdeburg



Biofilms

Sampling Location



Upper Harz Water Regale

- System of dams, reservoirs, ditches
- Built from 16th to 19th centuries
- Drove water wheels of the mines
- In 2010 declared as a UNESCO World Heritage Site

Sampling location "Schlüsselstollen"

- Gallery was built in 1879
- Drains the mining district at a length of 31 km



Courtesy of UFZ Magdeburg

Biofilms Sampling



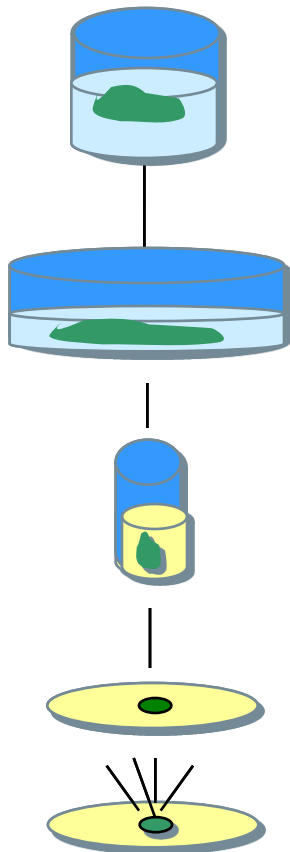
Grown on round polycarbonate slide



Courtesy of UFZ Magdeburg

Biofilms

Sample Preparation for TXRF



- Sampling and transport (4°C)
- Rinse with clean water
- Freeze drying
- Homogenization
- Weighing ca. 500 µg at Ultrabalance
- Digestion with $\text{HNO}_3/\text{H}_2\text{O}_2$
- Internal standard Sc
- 10 µl sample aliquot
- Drying on a hot plate 80°C

Analysis with TXRF

Accumulation Factors in Water and Biofilms

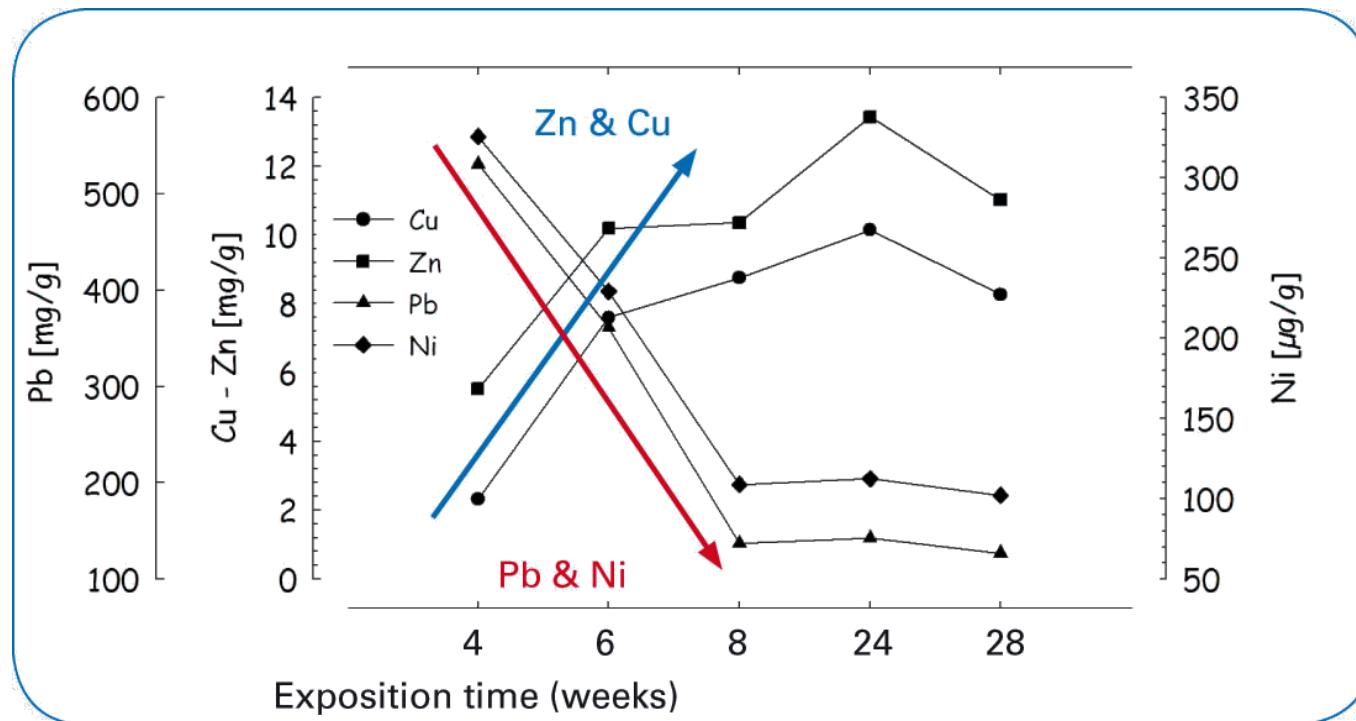


Element	Accumulation factor water*	Accumulation factor biofilm*
Pb	1400	2200
Zn	630	18
Cu	11	140
Ni	8	7

*) relation of gallery to creek water

Biofilms: Pb > Cu > Zn > Ni > Fe > Ca

Sorption Effects in Biofilms



- Immediate accumulation of Pb and Ni during growth
- Release during longer exposition
- Slow accumulation of Cu and Zn

Applications

Nanoparticle Characterization



Analytical question

- Element ratios in CdSe nanoparticles coated with ZnS

Analytical issues

- Extremely small sample amount (R&D)
- Non-destructive method preferred

TXRF measurement

- Transfer of nanoparticles to quartz carrier by cotton bud
- Standardless quantification



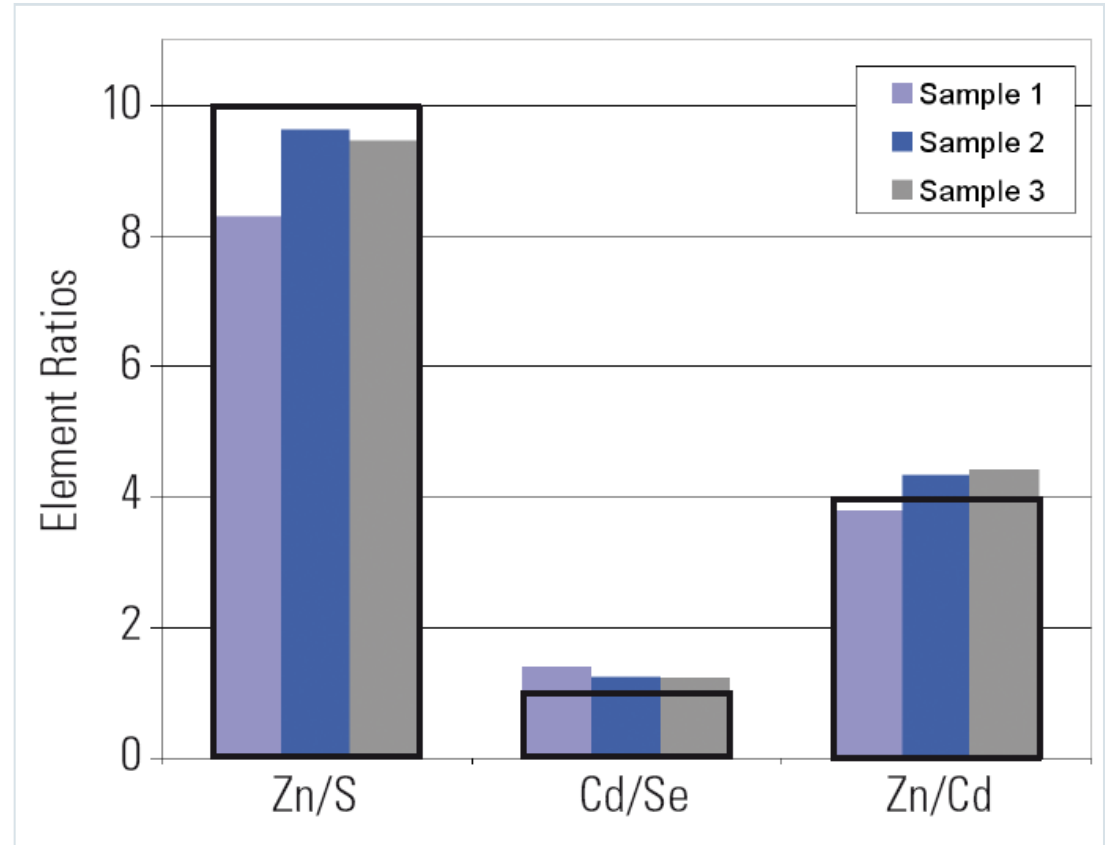
Applications

Nanoparticle Characterization



Results

- Even smallest sample amounts allow the determination of element ratios in nanoparticles
- S2 PICOFOX "Standardless" analysis applied



Measured ratios of 3 samples versus target value (\square)

Applications

Analysis of Nanoparticle Coating



Analytical task

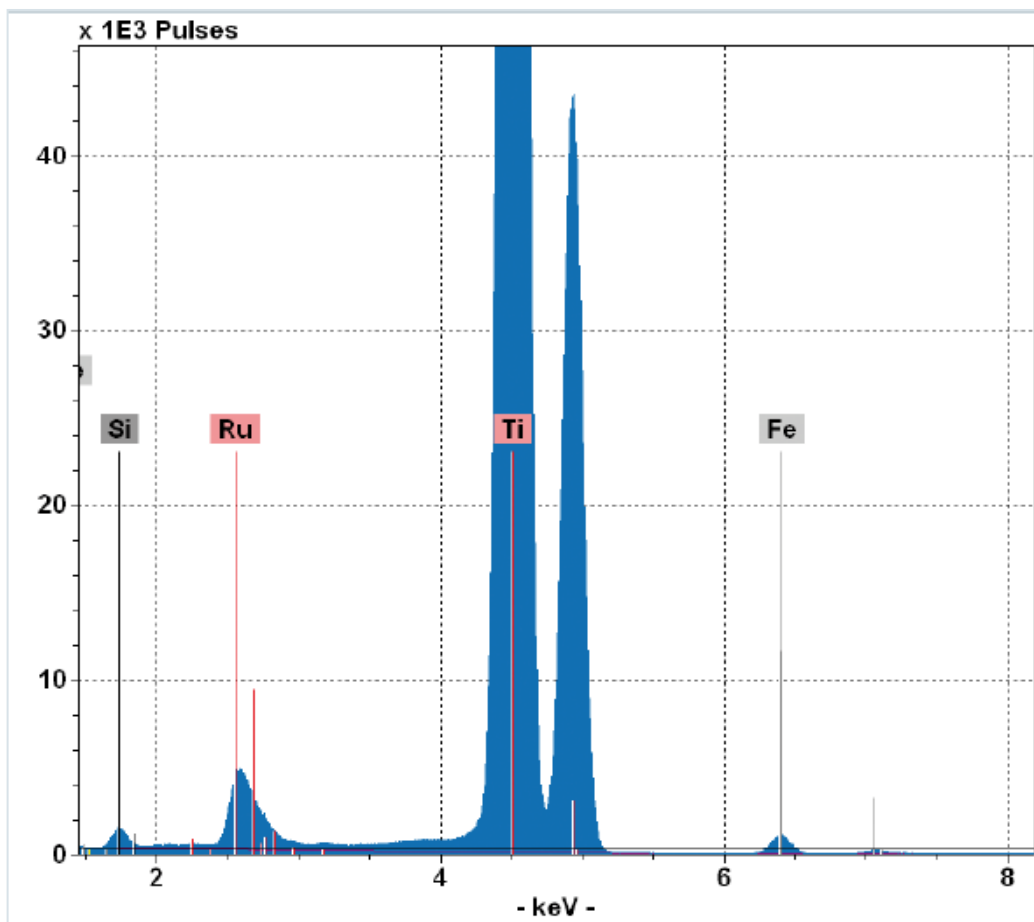
- Ru coating of TiO_2 nanoparticles

Sample preparation and measurement

- 40 mg resuspended in 2.5 ml Triton X-100
- Addition of Ga standard, homogenisation
- Transfer to quartz carrier, measuring time 120 s

Results

- The amount of Ru was calculated to 72 $\mu\text{g/l}$ (ICP: 65 $\mu\text{g/l}$)

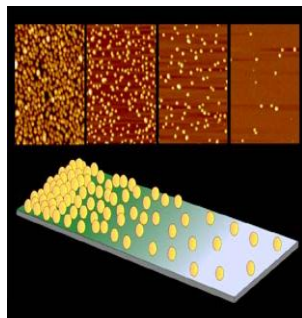


Studying Trace Elements

Studying Trace Elements



Analytical Chemistry



Materials Research



Environmental Chemistry

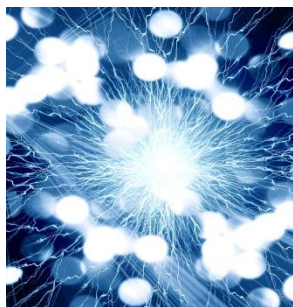


Forensics



Botany

Courses where TXRF is used



Physics



Biology



Undergraduate & Graduate Research



Geology

Comparison TXRF versus AAS & ICP-OES



Sample application

	TXRF	ICP-OES	AAS
Direct analysis of solids	Qualitative, quantitative with lower sensitivity	not possible	GF-AAS only
Sample amount	ng to μg range	mg range	mg range GF-AAS μg range

Comparison TXRF versus AAS & ICP-OES



During operation

	TXRF	ICP-OES	AAS
Multielement analysis	Yes	Yes	Sequential only
Standardless	Yes (with restrictions)	Yes	No
Meas. time	300 – 1000 s	<10 s per element	<10 s per element
Calibration	Internal standardization	External, element-specific, to be updated	External, element-specific, to be updated

Comparison TXRF versus AAS & ICP-OES



Cost of operation

	TXRF	ICP-OES	AAS
Consumables	(X-ray tube)	(Nebulizer parts)	Cathode lamps
Power consumption	Low (150 W)	High (HF generator 2.5 – 3.6 kW)	Low
Water consumption	none	> 0.5 l/min	~1.5 l/min (GF only)
Gas consumption	none	Carrier/burning gas (Ar, N ₂), 15-20 l/min	FAAS: burning gas (C ₂ H ₂), 1.5-8 l/min GF: Carrier gas (Ar, N ₂)

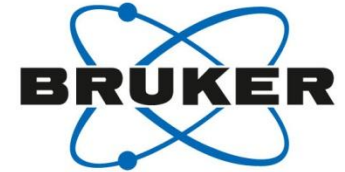
Comparison TXRF versus AAS & ICP-OES



Other practical issues

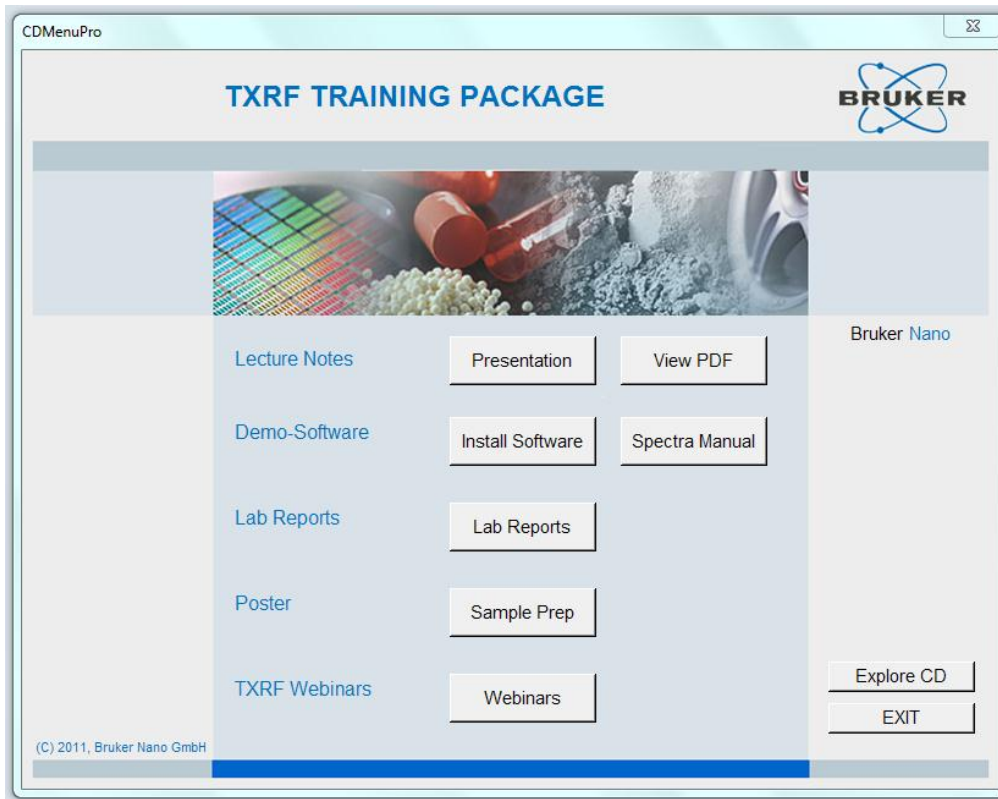
	TXRF	ICP-OES	AAS
Method recognition	Low	High	High
Maintenance needs	Low	High	Medium
Instrument size and weight	Compact benchtop 37 kg	Large benchtop 190 – 290 kg	Benchtop 30 – 200 kg
Mobile use	Yes	Impossible	Hardly possible
Online (LC)	no	yes	

Benefits of TXRF for Education and Research



- Low cost-of-ownership
- Little to no maintenance
- Fast learning curve
- Wide range of applications
- Great publication opportunities
- Benefits of teaching XRF with trace element analysis capabilities
- Multiple references
- NO NEED FOR ACID DIGESTION!
- Comes with Bruker TXRF Training Package
 - Free software for students
 - Example data
 - XRF PowerPoint slides for Professors

TXRF Training Package



- TXRF training package includes
 - Free software
 - Example data
 - Lab Reports
 - Lecture slides
 - Sample prep poster
 - Webinars
- Free to university customers

Any questions?

Please type any questions you may have for our speakers in the [Q&A panel](#) and click Send.



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Thank you!

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Webinar

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Nov 20, 2012

TXRF for Trace Element Analysis of Air, Land and Water

This one-hour live webinar demonstrates the capabilities of TXRF for trace element analysis of air (aerosol and filters), land (soils and sediments), and water (fresh and effluents). Learn about level of detection, ease-of-use, regulated analysis, and advantages of TXRF in various, everyday environmental applications.
[Register now](#)

Webinar

Content

Dec 13, 2010

Trace Element Analysis of Industrial Wastewater and Sewage with TXRF and ICP-MS

Join Mike Beauchaine and Andrew Toms as they present the capabilities of TXRF and ICP-MS for trace element analysis of wastewater. Learn about the combined advantages of the two techniques for routine, industrial and mobile lab testing.
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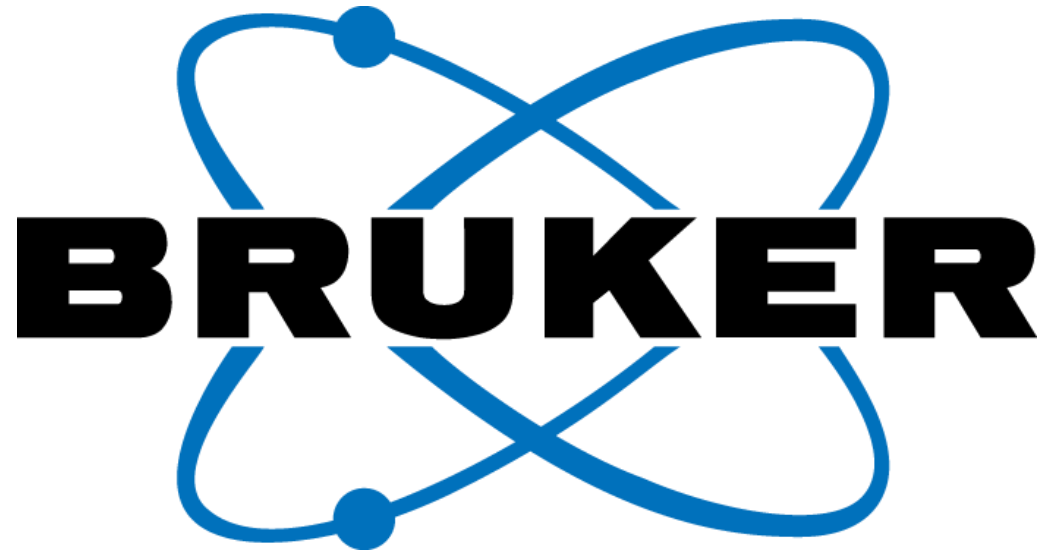
AEROMAT – Bellevue, WA - Apr 2-5

Cast Expo – St. Louis, MO - Apr 6-9

ACS Spring – New Orleans, LA - Apr 7-11

ICDD XRF Clinic – Newtown Square, PA - Apr 29 - May 3

AISTech – Pittsburgh, PA – May 6-9



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